LNA2801L

GaAlAs on GaAs Infrared Light Emitting Diode

For optical control systems

■ Features

- High-power output, high-efficiency: I_e = 6 mW/sr (min.)
- Emitted light spectrum suited for silicon photodetectors
- Good radiant power output linearity with respect to input current
- \$\phi 3\$ plastic package

■ Absolute Maximum Ratings $T_a = 25$ °C

Parameter	Symbol	Rating	Unit	
Power dissipation	P _D	75	mW	
Forward current	I_{F}	50	mA	
Pulse forward current *	I_{FP}	1	A	
Reverse voltage	V_R	3	V	
Operating ambient temperature	T _{opr}	-25 to +85	°C	
Storage temperature	T _{stg}	-40 to +100	°C	

Note) *: f = 100 Hz, Duty cycle = 0.1%

■ Electro-Optical Characteristics $T_a = 25^{\circ}C \pm 3^{\circ}C$

Parameter	Symbol	Conditions	Min	Тур	Max	Unit
Center radiant intensity	I _e	$I_F = 20 \text{ mA}$	6.0	C'IIII	0/8,	mW/sr
Reverse current	I_R	$V_R = 3 V$	5 196	5 6	10	μΑ
Forward voltage	V _F	$I_F = 50 \text{ mA}$	OIL.	1.3	1.5	V
Terminal capacitance	Ct	$V_R = 0 V, f = 1 MHz$	3 100	35		pF
Peak emission wavelength	$\lambda_{ m P}$	$I_F = 50 \text{ mA}$	60,	940		nm
Spectral half band width	Δλ	$I_F = 50 \text{ mA}$		50		nm
Half-power angle	θ	The angle when the center radiant intensity is halved.		15		0

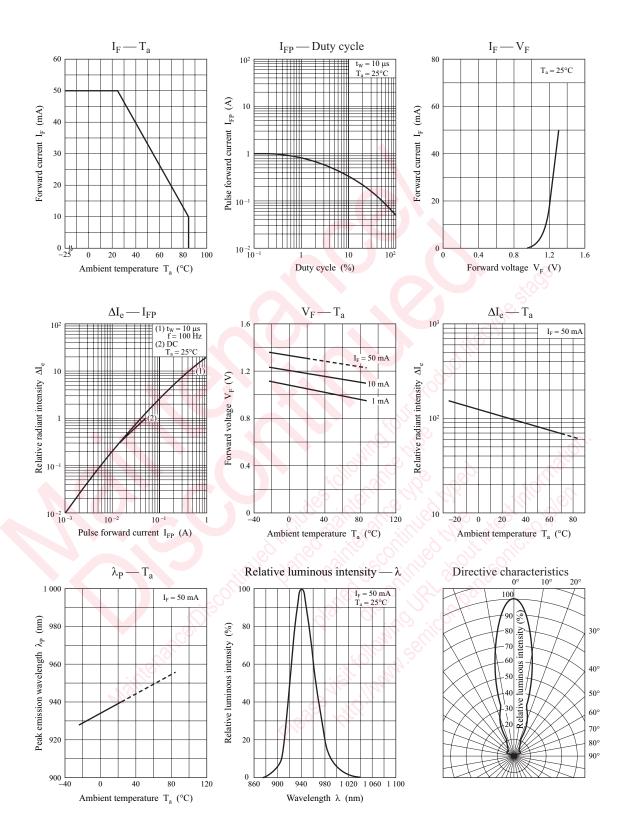
Note) 1. Measuring methods are based on JAPANESE INDUSTRIAL STANDARD JIS C 7031 measuring methods for diodes.

2. Cutoff frequency: 1 MHz

$$f_C: 10 \times log \frac{P_O \text{ at } f = f_C}{P_O \text{ at } f = 50 \text{ kHz}} = -3$$

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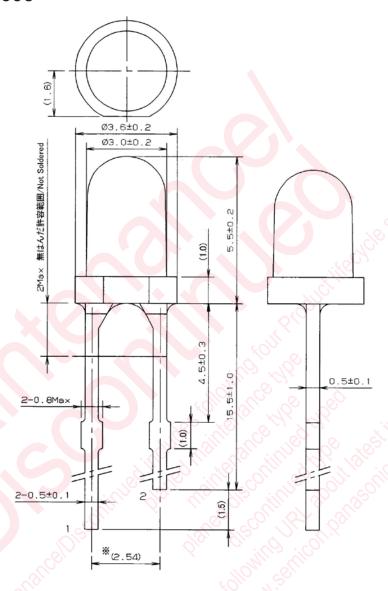


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■ Package (Unit: mm)

LEXLTN2S0006



- Pin name
 - 1: Anode
 - 2: Cathode

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